

| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|-------|------|--|---|------------------|---------|------------------|
| S1 | 1 | "20020131011".pn. | US-PGPUB; USPAT | OR | OFF | 2004/05/10 14:01 |
| S2 | 515 | electromagnetic adj detector | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 14:02 |
| S3 | 1598 | 349/158 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 14:04 |
| S4 | 61 | (electromagnetic adj detector) and charge | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/11 11:15 |
| S5 | 153 | (electromagnetic adj (detector measure\$4 test\$4))and charge | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 15:05 |
| S6 | 58 | (electromagnetic adj (detector measure\$4 test\$4))and charge and (uneven\$4 concave convex) and bond\$4 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 15:15 |
| S7 | 1068 | (electromagnetic adj (detector measure\$4 test\$4)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 15:15 |
| S8 | 52 | (electromagnetic adj (detector measure\$4 test\$4))and uneven and charge and semiconductor | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 16:14 |
| S9 | 328 | 349/199 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 15:31 |
| S10 | 2 | 349/199 and (uneven concave convex) and (semiconductor\$4 near10 charge) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 15:31 |

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|-----|------|--|---|----|----|------------------|
| S11 | 21 | 349/199 and (uneven concave convex) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 15:31 |
| S12 | 154 | 250/267 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 16:03 |
| S13 | 393 | 250/265 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 16:06 |
| S14 | 167 | 250/339.14 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 16:11 |
| S15 | 2 | (electromagnetic) and uneven and charge and ((semiconductor near10 (charge pixel)) same (convex or concave)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 16:17 |
| S16 | 3 | uneven and charge and ((semiconductor near10 (charge pixel)) same (convex or concave)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 16:25 |
| S17 | 8 | uneven and ((semiconductor near10 (charge or pixel)) same (convex or concave)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 17:10 |
| S18 | 25 | uneven and ((semiconductor near10 (charge or pixel)) and (convex or concave)) and peel\$4 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 17:11 |
| S19 | 177 | uneven and ((semiconductor near10 (charge or pixel)) and (convex or concave)) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/10 17:27 |
| S20 | 2702 | 257/59 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/11 11:17 |

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| S21 | 2252 | 257/72 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/11 11:16 |
| S22 | 0 | 257/72 and (electromagnetic adj detector) and charge | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/11 11:16 |
| S23 | 0 | 257/72 and (electromagnetic adj detector) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/05/11 11:17 |
| S24 | 0 | 257/59 and (electromagnetic adj detector) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2004/05/11 11:18 |